

# International Rectifier

PD - 94592A

## IRF6156

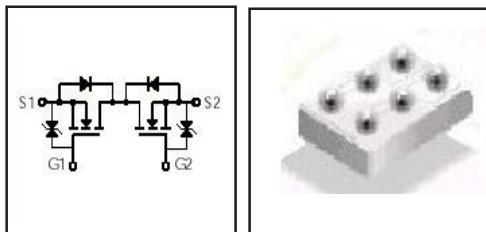
FlipFET™ Power MOSFET

- Ultra Low  $R_{SS(on)}$  per Footprint Area
- Low Thermal Resistance
- Bi-Directional N-Channel Switch
- Super Low Profile (<.8mm)
- Available Tested on Tape & Reel
- ESD Protection Diode ®

<b>V<sub>SS</sub></b>	<b>R<sub>SS(on)</sub> max</b>	<b>I<sub>S</sub></b>
<b>20V</b>	<b>40mΩ@V<sub>GS1,2</sub> = 4.5V</b>	<b>±6.5</b>
	<b>60mΩ@V<sub>GS1,2</sub> = 2.5V</b>	<b>±5.2</b>

### Description

True chip-scale packaging is available from International Rectifier. Through the use of advanced processing techniques and a unique packaging concept, extremely low on-resistance and the highest power densities in the industry have been made available for battery and load management applications. These benefits, combined with the ruggedized device design that International Rectifier is well known for, provide the designer with an extremely efficient and reliable device.



The FlipFET™ package, is one-fifth the footprint of a comparable TSSOP-8 package and has a profile of less than .8mm. Combined with the low thermal resistance of the die level device, this makes the FlipFET™ the best device for applications where printed circuit board space is at a premium and in extremely thin application environments such as battery packs, mobile phones and PCMCIA cards.

### Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>SS</sub>	Source-to-Source Voltage	20	V
I <sub>S</sub> @ T <sub>A</sub> = 25°C	Continuous Current, V <sub>GS1</sub> = V <sub>GS2</sub> = 4.5V ③	±6.5	A
I <sub>S</sub> @ T <sub>A</sub> = 70°C	Continuous Current, V <sub>GS1</sub> = V <sub>GS2</sub> = 4.5V ③	±5.2	
I <sub>SM</sub>	Pulsed Current ①	33	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Power Dissipation ③	2.5	W
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Power Dissipation ③	1.6	
	Linear Derating Factor	20	mW/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±12	V
T <sub>J</sub>	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		

### Thermal Resistance

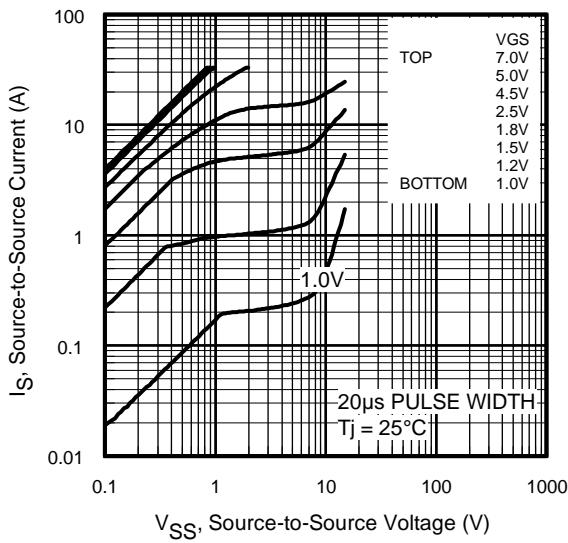
	Parameter	Typ.	Max.	Units
R <sub>θJA</sub>	Junction-to-Ambient ③	—	50	°C/W
R <sub>θJ-PCB</sub>	Junction-to-PCB	35	—	

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

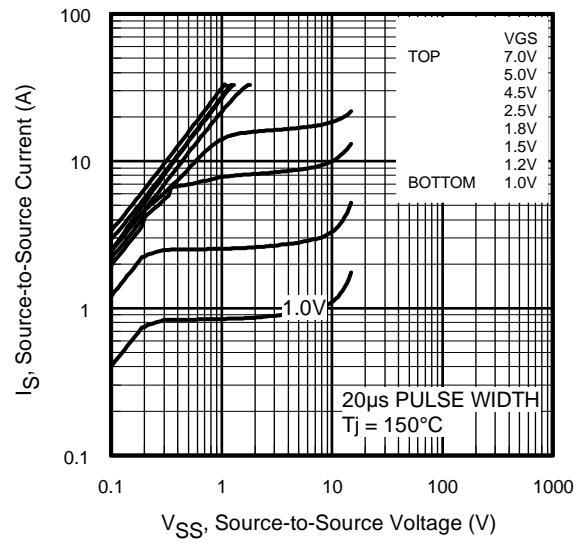
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{SSS}}$	Source-to-Source Breakdown Voltage	20	—	—	V	$V_{GS}=0V$ , $I_S=250\mu\text{A}$ , See Fig. 23a&b
$\Delta V_{(\text{BR})\text{SSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	16	—	mV/°C	Reference to $25^\circ\text{C}$ , $I_S=1\text{mA}$ , Fig.23a&b
$R_{\text{SS}(\text{on})}$	Static Source-to-Source On-Resistance	—	27	40	mΩ	$V_{GS1,2} = 4.5\text{V}$ , $I_S = 6.5\text{A}$ ② Fig.11a&b
		—	43	60		$V_{GS1,2} = 2.5\text{V}$ , $I_S = 5.2\text{A}$ ②
$V_{GS(\text{th})}$	Gate Threshold Voltage	0.45	—	1.2	V	$V_{SS} = V_{GS}$ , $I_S = 250\mu\text{A}$ ② Fig. 10a&b
$g_{fs}$	Forward Transconductance	18	—	—	S	$V_{SS} = 10\text{V}$ , $I_S = 6.5\text{A}$ , See Fig. 4
$I_{\text{SSS}}$	Zero Gate Voltage Source Current	—	—	1.0	μA	$V_{SS} = 20\text{V}$ , $V_{GS} = 0\text{V}$ , See Fig.23a&b
		—	—	25		$V_{SS} = 16\text{V}$ , $V_{GS} = 0\text{V}$ , $T_J = 125^\circ\text{C}$
		—	50	—	nA	$V_{SS} = 4.5\text{V}$ , $V_{GS} = 0\text{V}$ , $T_J = 25^\circ\text{C}$
		—	100	—		$V_{SS} = 4.5\text{V}$ , $V_{GS} = 0\text{V}$ , $T_J = 60^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	8.0	20	μA	$V_{GS} = 12\text{V}$ , See Fig. 22
	Gate-to-Source Reverse Leakage	—	-8.0	-20		$V_{GS} = -12\text{V}$
	Gate-to-Source Forward Leakage	—	0.20	0.5	μA	$V_{GS} = 4.5\text{V}$
	Gate-to-Source Reverse Leakage	—	-0.20	-0.5		$V_{GS} = -4.5\text{V}$
$Q_g$	Total Gate Charge	—	12	18	nC	$I_S = 6.5\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	1.6	2.4		$V_{SS} = 16\text{V}$
$Q_{G1-S2}$	Miller Charge	—	4.4	6.6		$V_{GS} = 5.0\text{V}$ , See Fig. 14a,b&c
$t_{d(on)}$	Turn-On Delay Time	—	8.0	—		$V_{SS} = 10\text{V}$
$t_r$	Rise Time	—	13	—	ns	$I_S = 1.0\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	33	—		$R_G = 3.0\Omega$
$t_f$	Fall Time	—	26	—		$V_{GS} = 5.0\text{V}$ , See Fig. 21a,b&c
$C_{iss}$	Input Capacitance	—	950	—		$V_{GS} = 0\text{V}$
$C_{oss}$	Output Capacitance	—	210	—	pF	$V_{SS} = 15\text{V}$
$C_{rss}$	Reverse Transfer Capacitance	—	150	—		$f = 1.0\text{KHz}$ , See Fig. 13a,b,c,d,e&f
$V_{ssf}$	Source-to-Source Diode Forward Voltage, One Device On	—	—	1.2	V	See Fig. 17a&b $I_{ss} = 2.5\text{A}$

**Notes:**

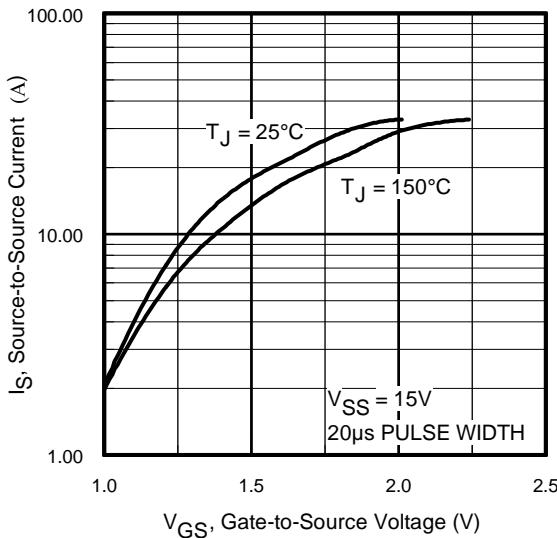
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ . Gate voltage applied to both gates.
- ③ When mounted on 1 inch square 2oz copper on FR-4.
- ④ Figures 1, 2 and 3: One Fet is biased with  $V_{GS} = 9.0\text{V}$  and curves show response of the second FET. See Fig.4.
- ⑤ Figures 5, 6 and 7: G1 and G2 are shorted. See Fig.9a&b.
- ⑥ The diode connected between the gate and source serves only as protection against ESD. No gate over voltage rating is implied.



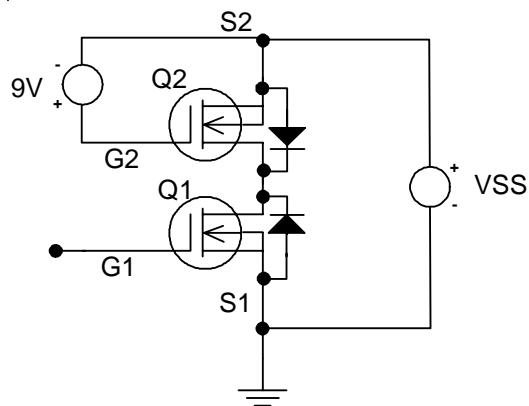
**Fig 1.** Typical Output Characteristics. ④



**Fig 2.** Typical Output Characteristics. ④



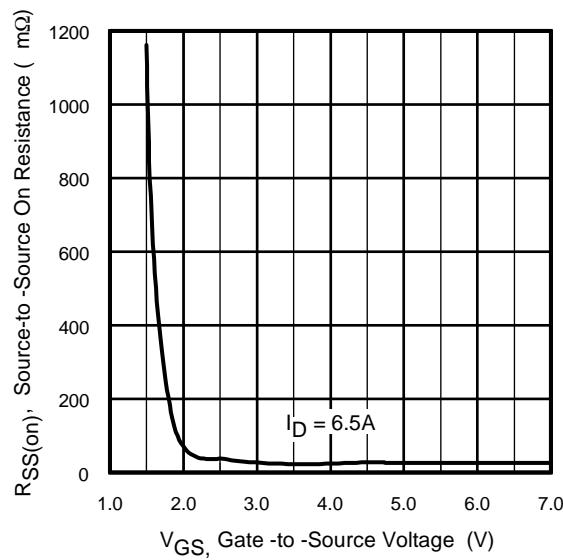
**Fig 3.** Typical Transfer Characteristics. ④



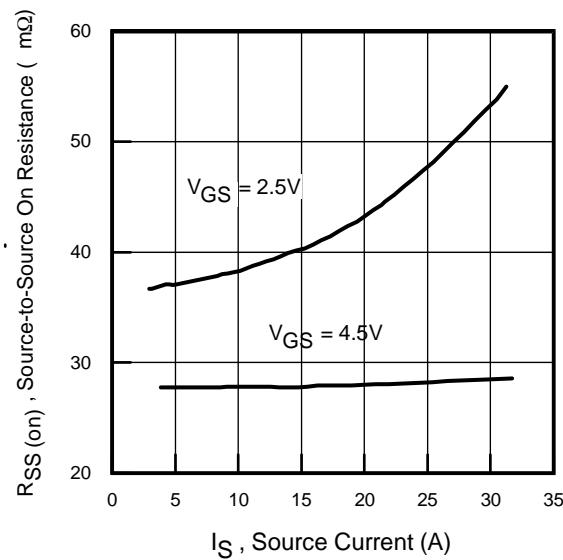
**Fig 4.** Output and Transfer Test Circuit.

# IRF6156

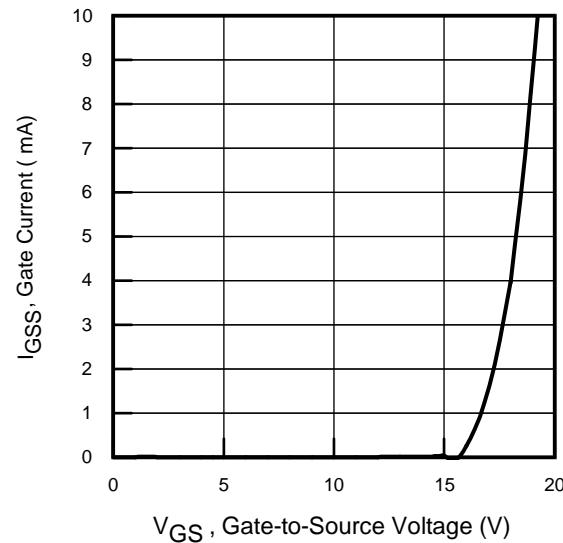
International  
**IR** Rectifier



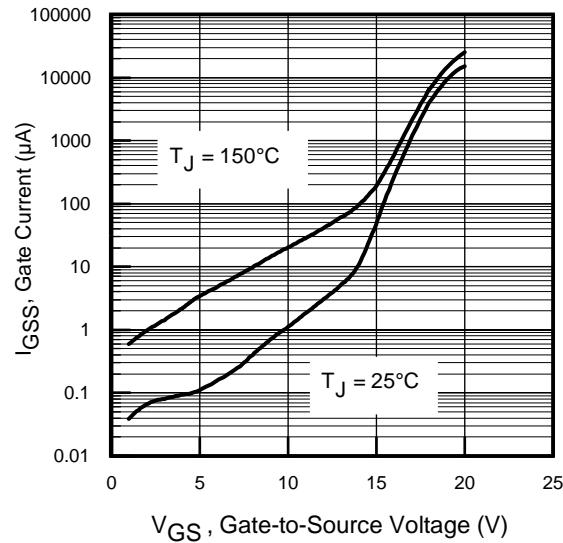
**Fig 5.** Typical On-Resistance vs. Gate Voltage. ⑤



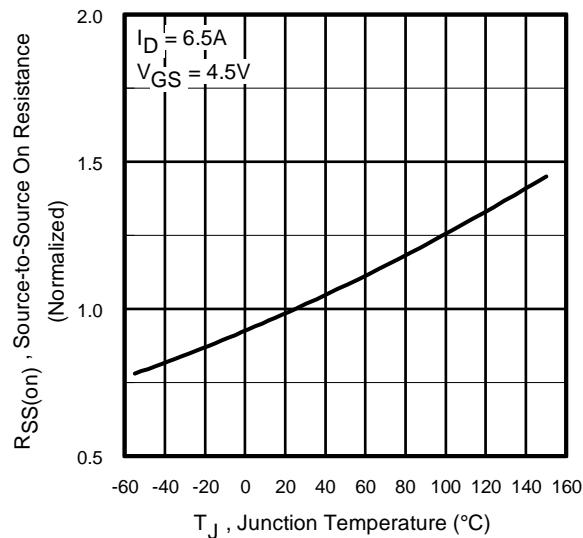
**Fig 6.** Typical On-Resistance vs. Source Current. ⑤



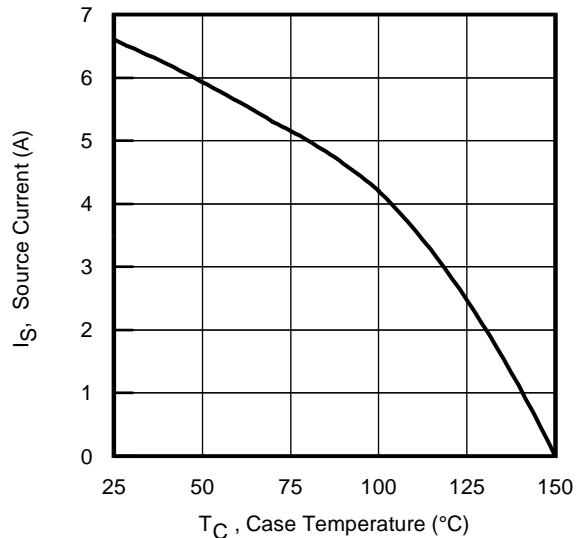
**Fig 7a.** Gate-Current vs. Gate-Source Voltage



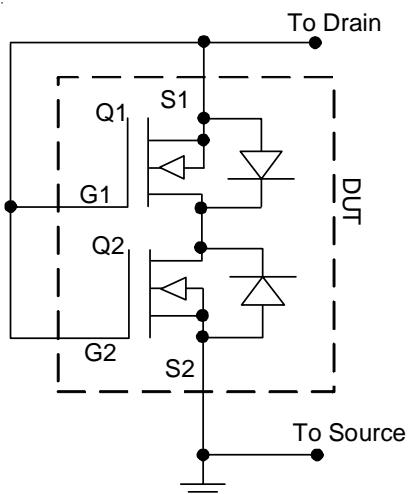
**Fig 7b.** Gate-Current vs. Gate-Source Voltage



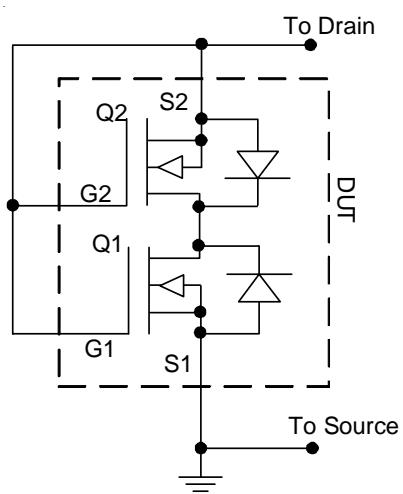
**Fig 8.** Normalized On-Resistance vs. Temperature. ⑤



**Fig 9.** Maximum Source Current vs. Case Temperature.



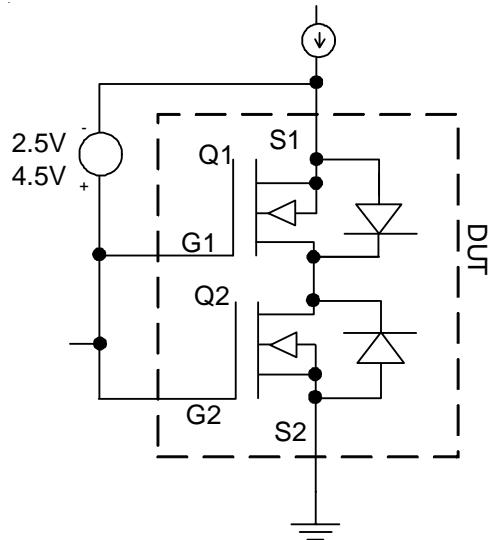
**Fig 10a.** V<sub>GS(th)</sub> is symmetrical and can be measured when connected as shown on figure 10a.



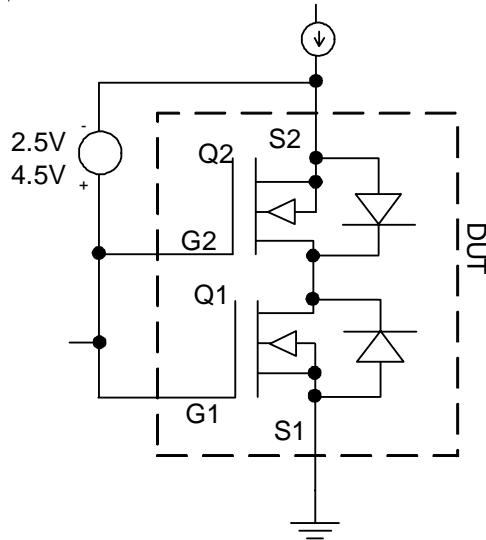
**Fig 10b.** V<sub>GS(th)</sub> is symmetrical and can be measured when connected as shown on figure 10b.

# IRF6156

International  
**IR** Rectifier

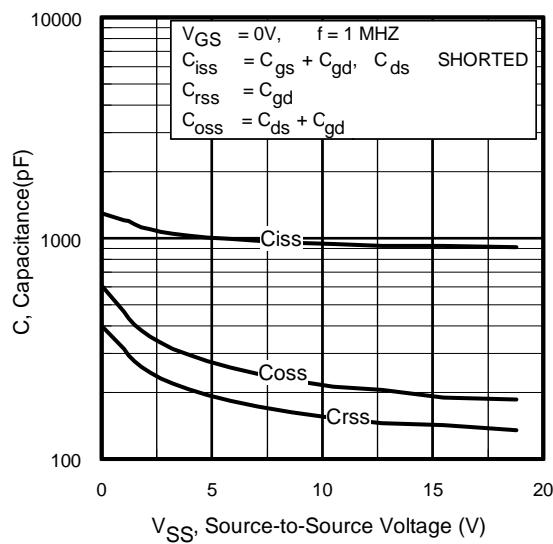


**Fig 11a**

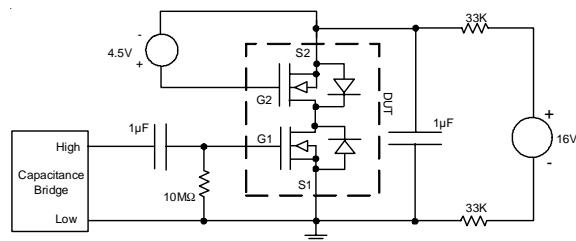


**Fig 11b**

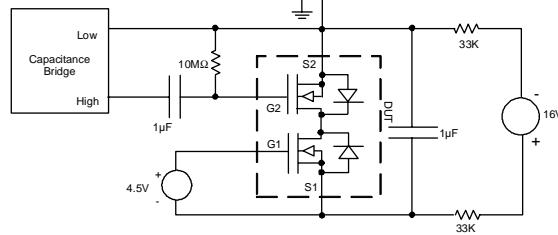
$R_{SS(on)}$  is symmetrical and can be measured when connected as shown in either figures 11a or 11b.



**Fig 12.** Typical Capacitance vs.  
Source-to-Source Voltage.

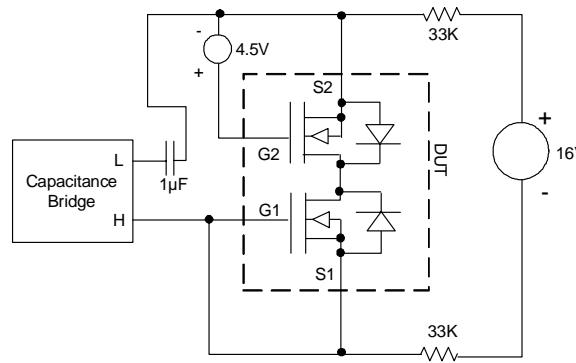


**Fig 13a**

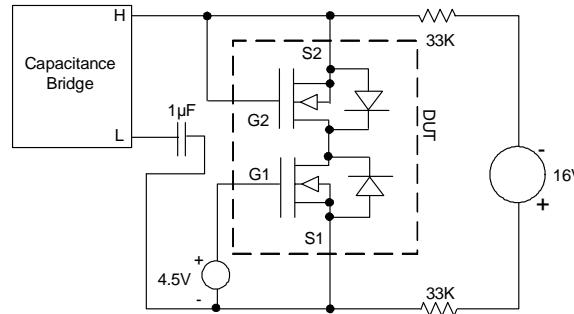


**Fig 13b**

Ciss capacitance is symmetrical and can be measured as shown either in figures 13a or 13b.

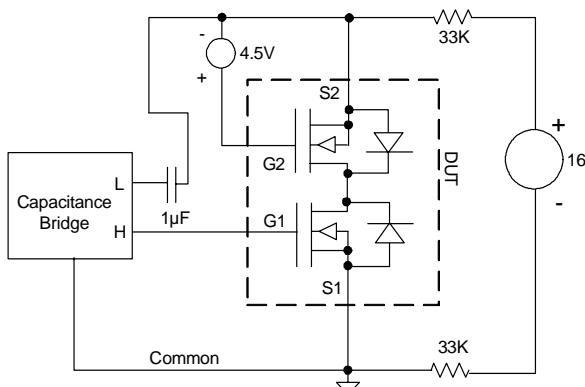


**Fig 13c**

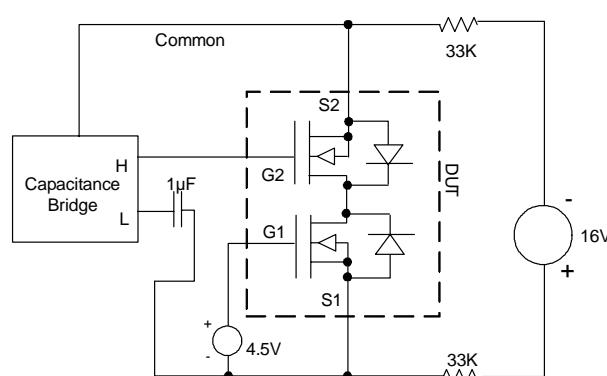


**Fig 13d**

Coss capacitance is symmetrical and can be measured as shown either in figures 13c or 13d.



**Fig 13e**

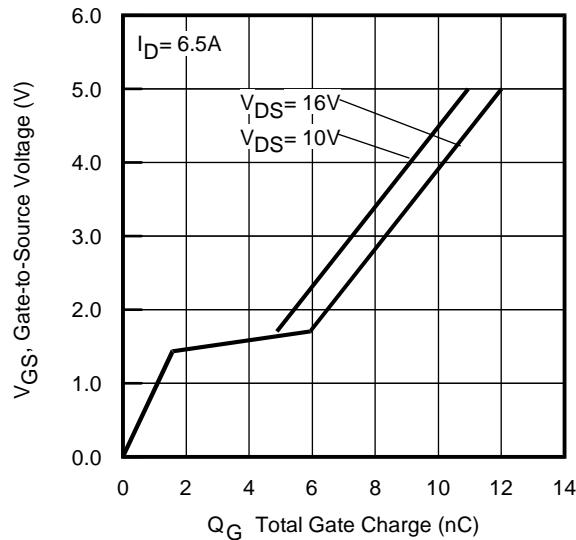


**Fig 13f**

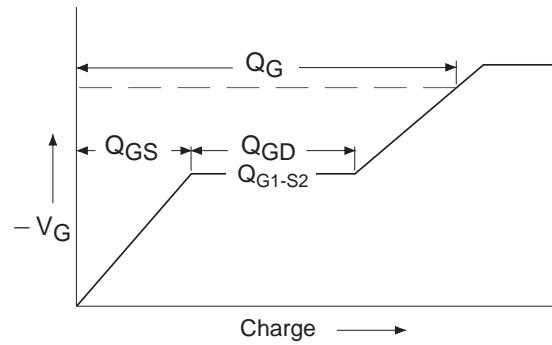
Crss capacitance is symmetrical and can be measured as shown either in figures 13e or 13f.

# IRF6156

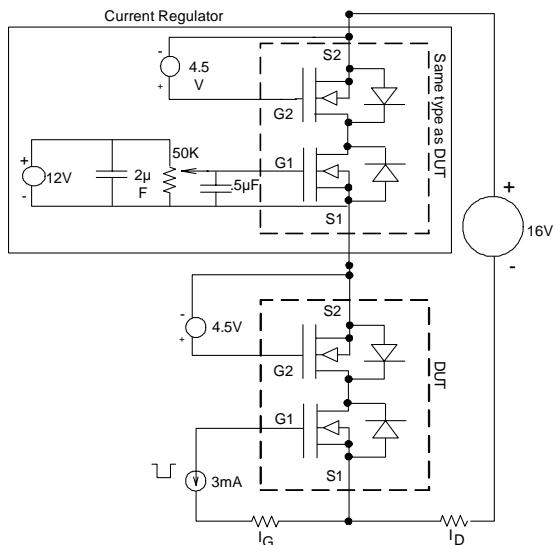
International  
**IR** Rectifier



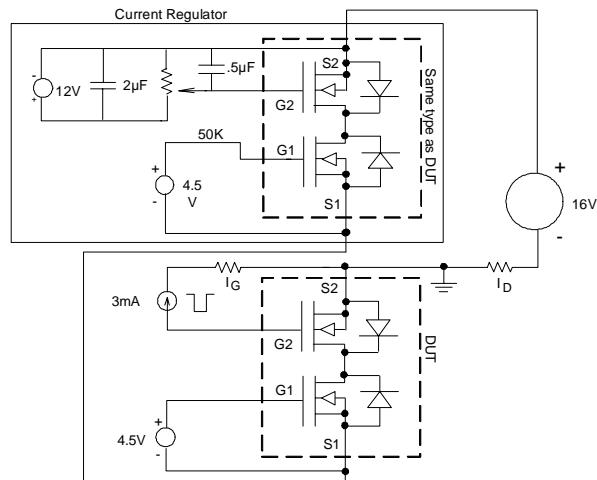
**Fig 14.** Typical Gate Charge vs. Gate-to-Source Voltage.



**Fig 14a.** Basic Gate Charge Waveform.

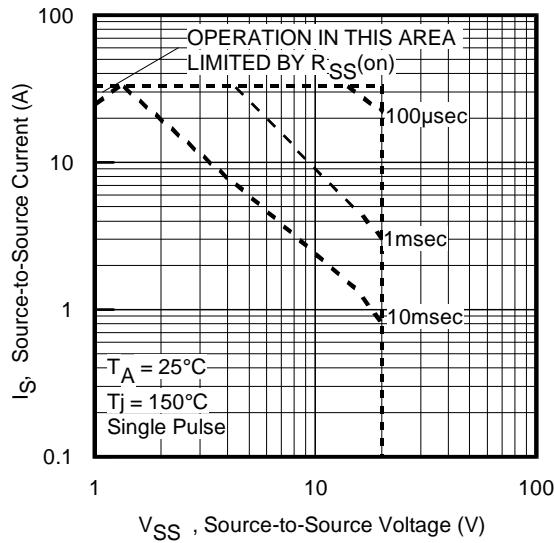


**Fig 14b**

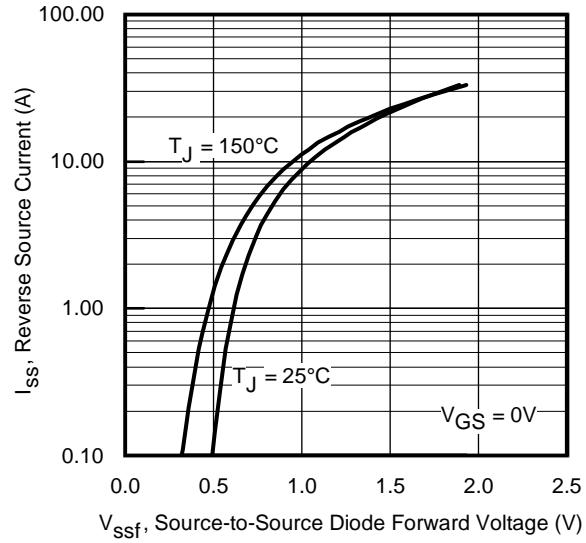


**Fig 14c**

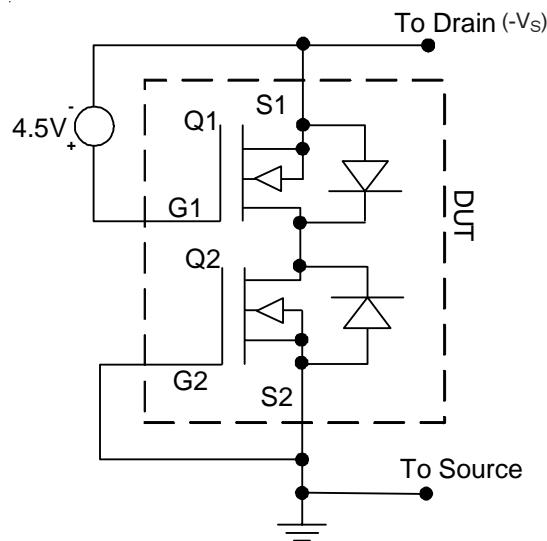
Gate Charge is symmetrical and can be measured as shown in either figures 14b or 14c.



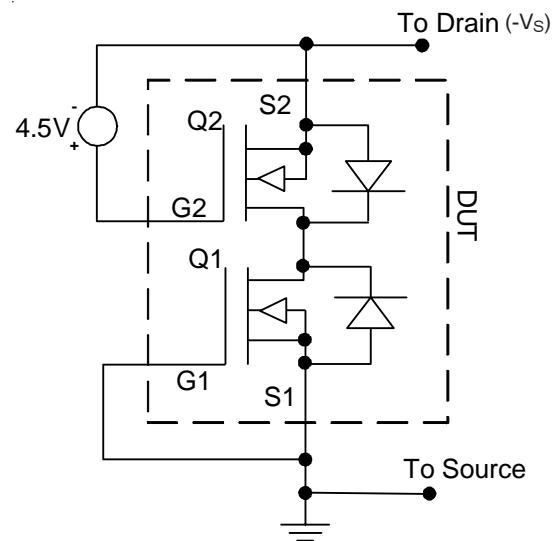
**Fig 15.** Maximum Safe Operating Area.



**Fig 16.** Typical Source-Source Diode Forward Voltage.  
 (See Fig.17a&b for Connection)



**Fig 17a**

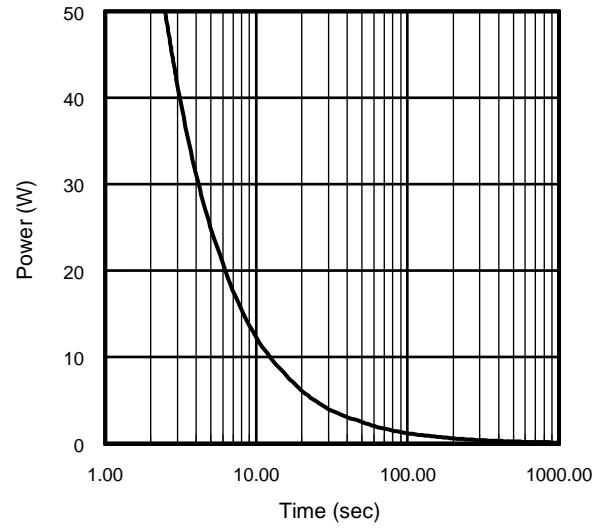


**Fig 17b**

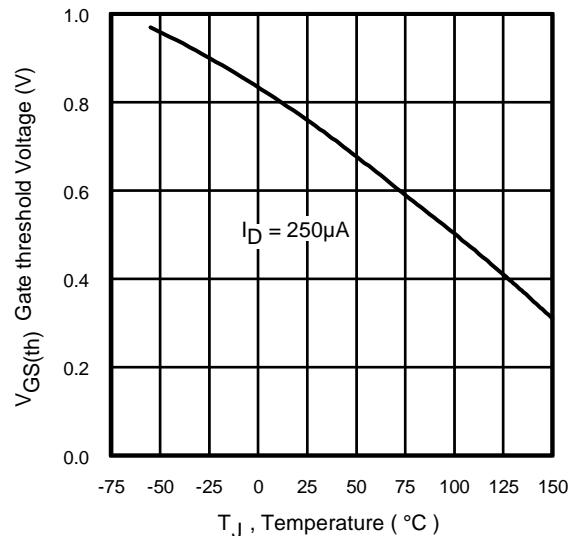
$V_{ssf}$  is symmetrical and can be measured when connected as shown either in figures 17a or 17b.

# IRF6156

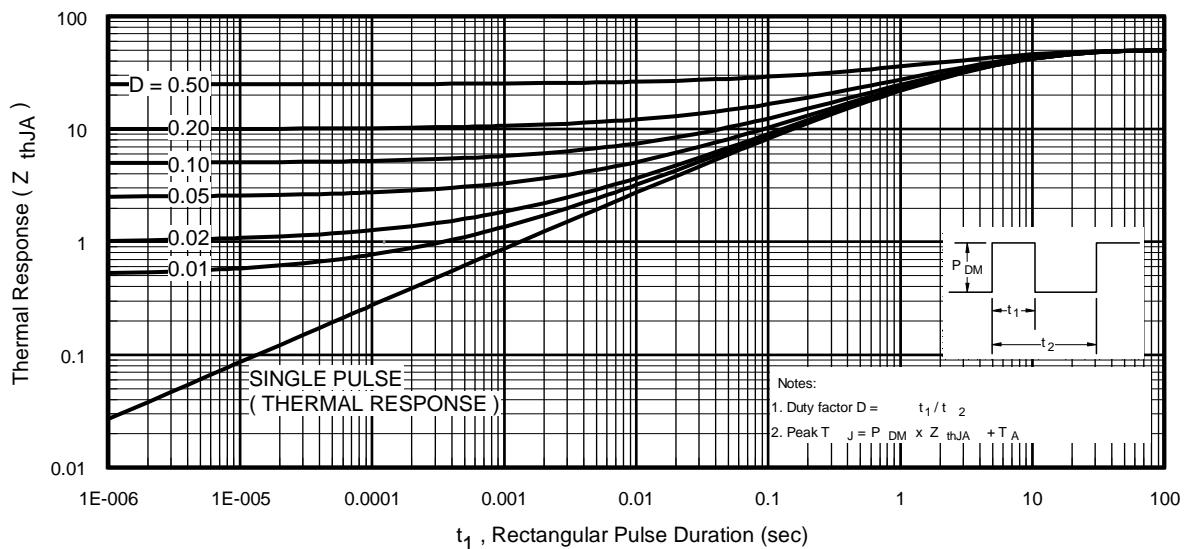
International  
**IR** Rectifier



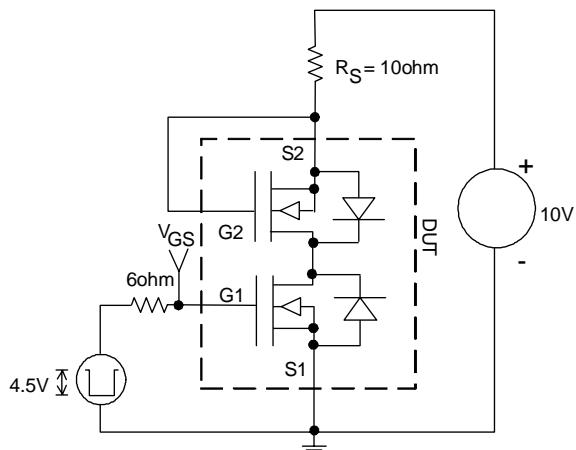
**Fig 18.** Typical Power vs. Time.



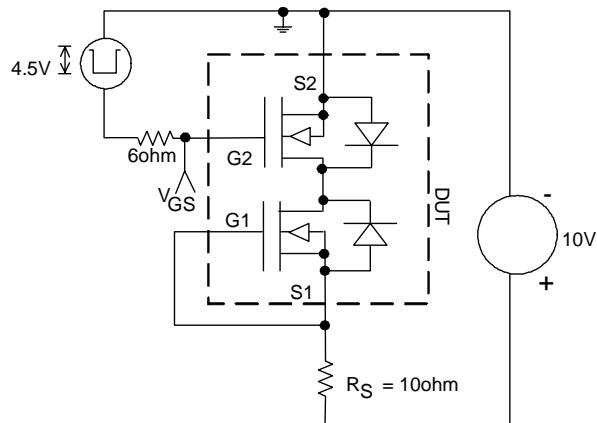
**Fig 19.** Threshold Voltage vs. Temperature.



**Fig 20.** Typical Effective Transient Thermal Impedance, Junction-to-Ambient.

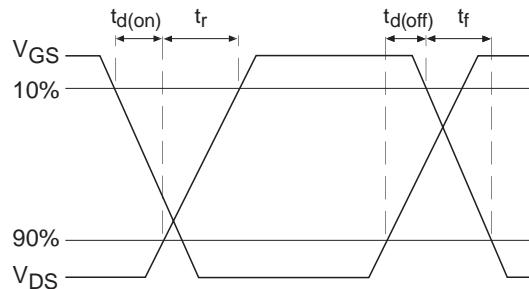


**Fig 21a**



**Fig 21b**

Switching times are symmetrical and can be measured as shown in either figures 21a or 21b.



**Fig 21c.** Switching Time Waveforms.

# IRF6156

International  
Rectifier

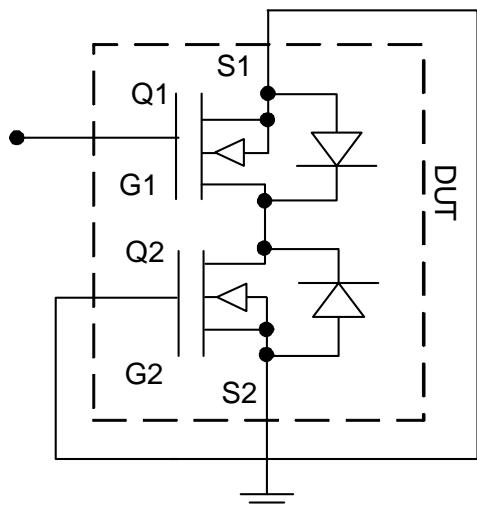


Fig 22a

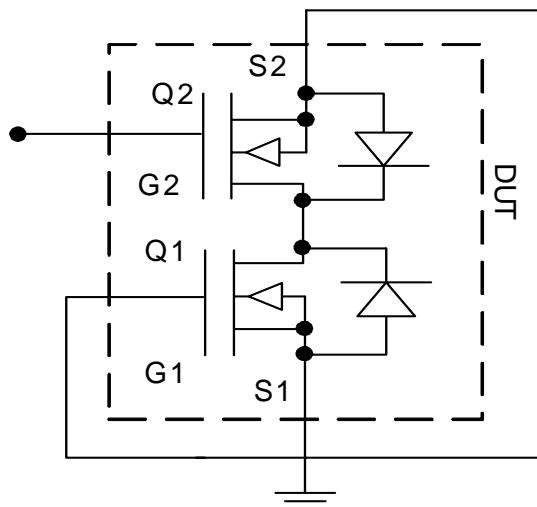


Fig 22b

$I_{GSS}$  Test Connection

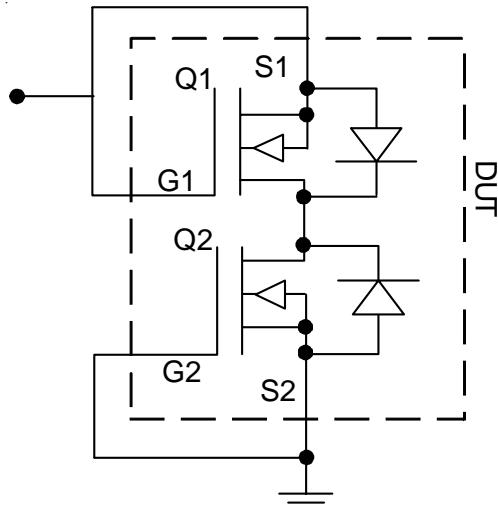


Fig 23a

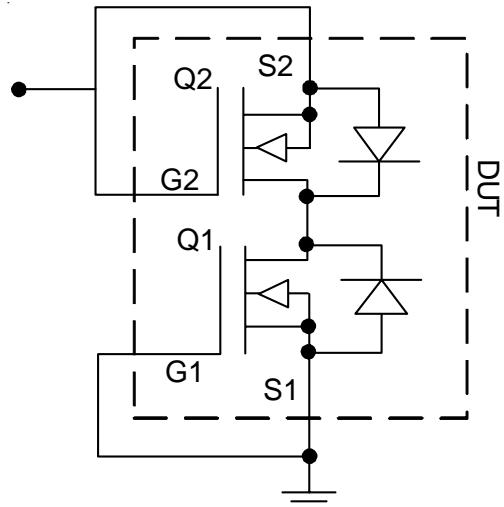
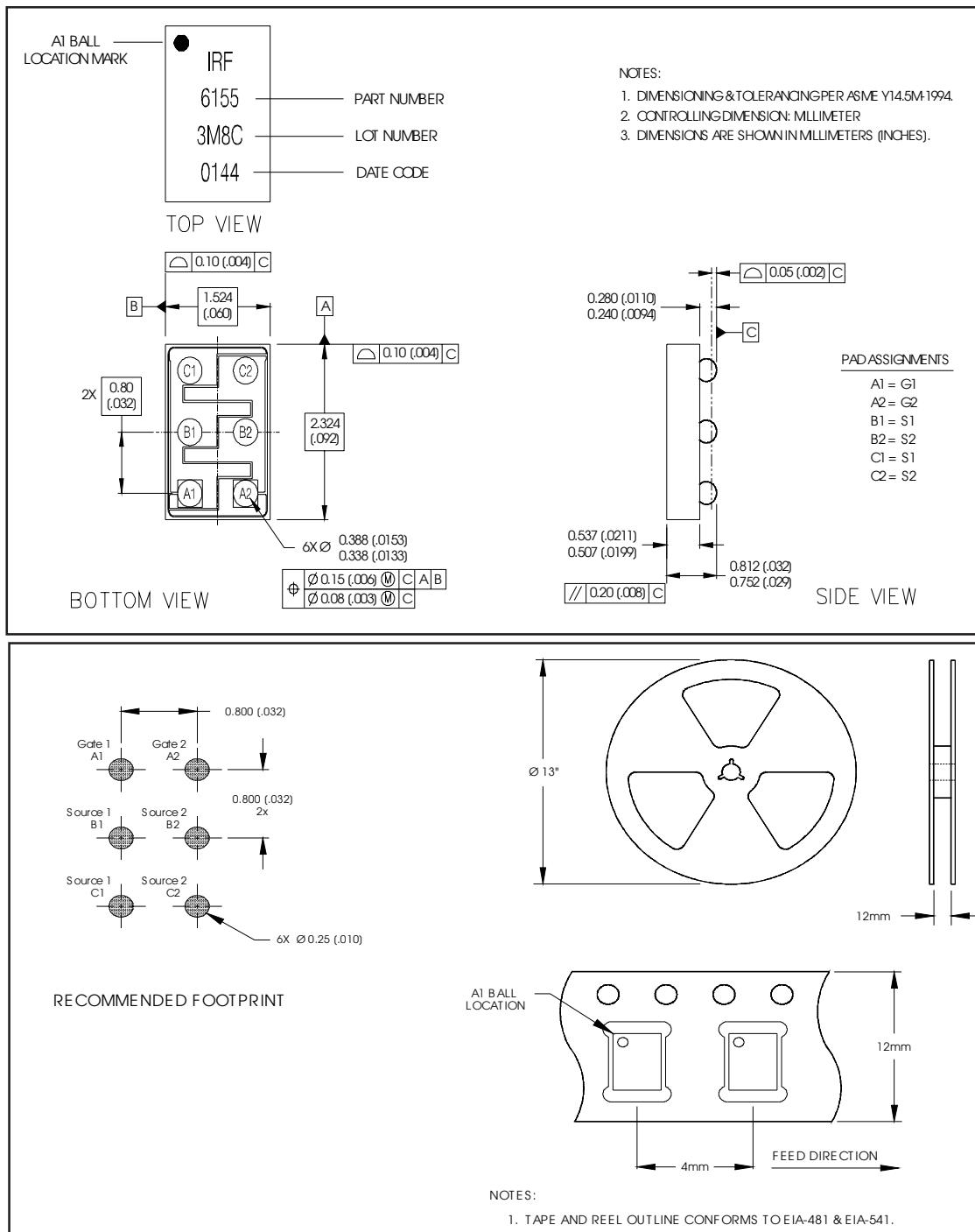


Fig 23b

$I_{SSS}$  and  $V_{(BR)SSS}$  are symmetrical and can be measured when connected either as figures 23a or 23b.

Bi-Directional MOSFET Pinout Outline Dimension and Tape and Reel Information  
Drawing No. 01-0115



Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903

Visit us at [www.irf.com](http://www.irf.com) for sales contact information.09/03